

**• General Description**

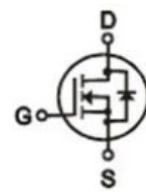
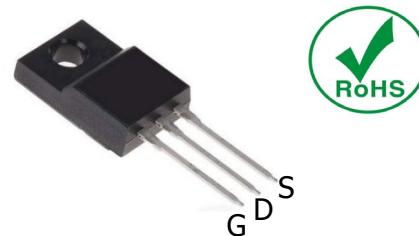
The ZM027N03F combines advanced trench MOSFET technology with a low resistance package to provide extremely low $R_{DS(ON)}$. This device is ideal for load switch and battery protection applications.

• Features

- Advance high cell density Trench technology
- Low $R_{DS(ON)}$ to minimize conductive loss
- Low Gate Charge for fast switching
- Low Thermal resistance

• Application

- MB/VGA Vcore
- SMPS 2nd Synchronous Rectifier
- POL application
- BLDC Motor driver

• Product Summary $V_{DS} = 30V$ $R_{DS(ON)} = 2.7m\Omega$ $I_D = 80A$ 

TO-220F

• Ordering Information:

| | |
|---------------------------|-----------|
| Part NO. | ZM027N03F |
| Marking | ZM027N03 |
| Packing Information | Bulk Tube |
| Basic ordering unit (pcs) | 500 |

• Absolute Maximum Ratings ($T_c = 25^\circ C$)

| Parameter | Symbol | Rating | Unit |
|-----------------------------------|---------------------------|------------|------------|
| Drain-Source Voltage | V_{DS} | 30 | V |
| Gate-Source Voltage | V_{GS} | ± 20 | V |
| Continuous Drain Current | $I_D @ T_c = 25^\circ C$ | 80 | A |
| | $I_D @ T_c = 75^\circ C$ | 61 | A |
| | $I_D @ T_c = 100^\circ C$ | 50 | A |
| Pulsed Drain Current ^① | I_{DM} | 210 | A |
| Total Power Dissipation | $P_D @ T_c = 25^\circ C$ | 120 | W |
| Total Power Dissipation | $P_D @ T_A = 25^\circ C$ | 5 | W |
| Operating Junction Temperature | T_J | -55 to 150 | $^\circ C$ |
| Storage Temperature | T_{STG} | -55 to 150 | $^\circ C$ |
| Single Pulse Avalanche Energy | E_{AS} | 180 | mJ |
| Avalanche Current | $I_{AS} I_{AR}$ | 60 | A |

**•Thermal resistance**

| Parameter | Symbol | Min. | Typ. | Max. | Unit |
|---|-------------------|------|------|------|-------|
| Thermal resistance, junction - case | R _{thJC} | - | - | 1.1 | ° C/W |
| Thermal resistance, junction - ambient | R _{thJA} | - | - | 25 | ° C/W |
| Soldering temperature, wave soldering for 10s | T _{sold} | - | - | 265 | ° C |

•Electronic Characteristics

| Parameter | Symbol | Condition | Min. | Typ | Max. | Unit |
|-----------------------------------|---------------------|--|------|-----|------|------|
| Drain-Source Breakdown Voltage | BV _{DSS} | V _{GS} =0V, I _D =250uA | 30 | | | V |
| Gate Threshold Voltage | V _{GS(TH)} | V _{GS} =V _{DS} , I _D =250uA | 1.2 | | 2.5 | V |
| Drain-Source Leakage Current | I _{DSS} | V _{DS} =30V, V _{GS} =0V | | | 1.0 | uA |
| Gate- Source Leakage Current | I _{GSS} | V _{GS} =±20V, V _{DS} =0V | | | ±100 | nA |
| Static Drain-source On Resistance | R _{DS(ON)} | V _{GS} =10V, I _D =24A | | 2.7 | 3.6 | mΩ |
| | | V _{GS} =4.5V, I _D =12A | | 4.1 | 5.5 | mΩ |
| Forward Transconductance | g _{FS} | V _{DS} =25V, I _D =10A | | 30 | | s |
| Source-drain voltage | V _{SD} | I _S =24A | | | 1.28 | V |

•Dynamic Characteristics

| Parameter | Symbol | Condition | Min. | Typ | Max. | Unit |
|------------------------------|---------------------|---|------|------|------|------|
| Input capacitance | C _{iss} | f = 1MHz, V _{DS} =25V | - | 2800 | - | pF |
| Output capacitance | C _{oss} | | - | 420 | - | |
| Reverse transfer capacitance | C _{rss} | | - | 280 | - | |
| Gate Resistance | R _g | f = 1MHz | | 2.5 | | Ω |
| Total gate charge | Q _g | V _{DD} = 25V I _D = 8A V _{GS} = 10V | - | 27 | - | nC |
| Gate - Source charge | Q _{gs} | | - | 8.6 | - | |
| Gate - Drain charge | Q _{gd} | | - | 13.8 | - | |
| Turn-ON Delay time | t _{D(on)} | V _{GS} =10V, V _{DS} =15V R _G =3.3Ω, I _D =15A | | 12 | | ns |
| Turn-ON Rise time | t _r | | | 44 | | ns |
| Turn-Off Delay time | t _{D(off)} | | | 50 | | ns |
| Turn-Off Fall time | t _f | | | 15 | | ns |
| Reverse Recovery Time | t _{RR} | | | 5.8 | | ns |



| | | | | | | |
|-------------------------|----------|--|--|-----|--|----|
| Charge Time | t_a | $V_{DD} = 20 \text{ V}$, $dIS/dt=100\text{A}/\mu\text{s}$, $IS = 30 \text{ A}$ | | 3.4 | | ns |
| Discharge Time | t_b | | | 2.4 | | ns |
| Reverse Recovery Charge | Q_{RR} | | | 1.6 | | nC |

Note: ① Pulse Test : Pulse width $\leq 300\mu\text{s}$, Duty cycle $\leq 2\%$;

Fig.1 Power Dissipation

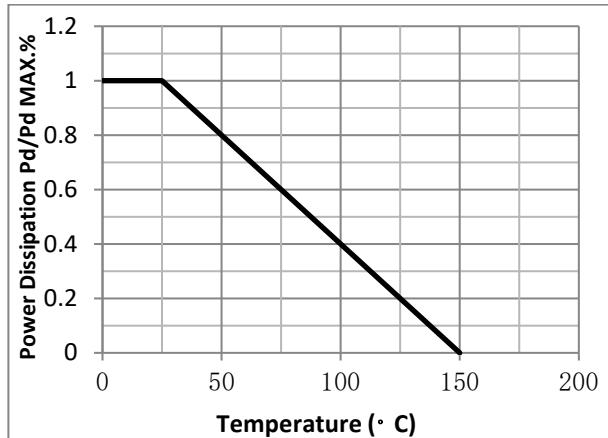


Fig.2 Typical output Characteristics

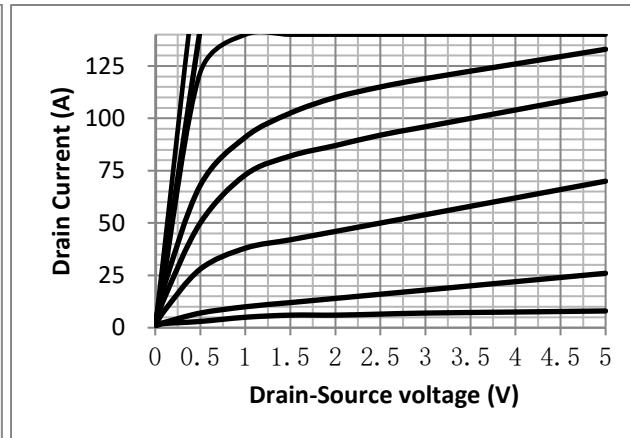


Fig.3 Threshold Voltage V.S Junction Temperature

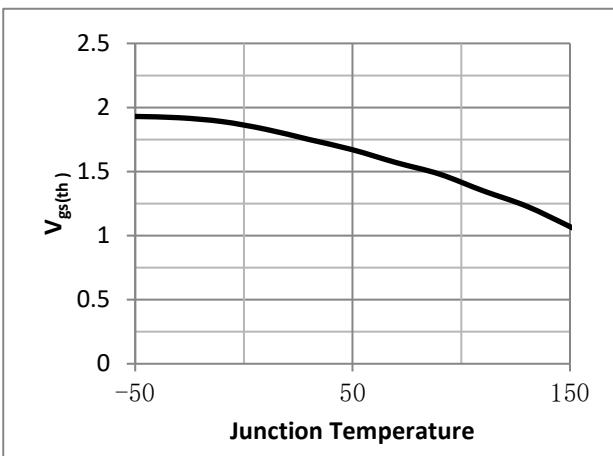


Fig.4 Resistance V.S Drain Current

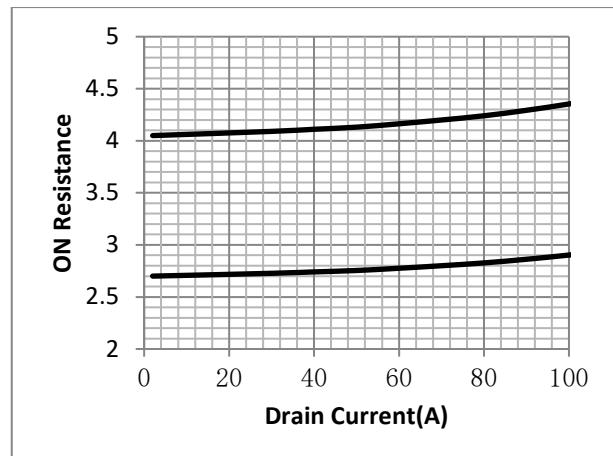




Fig.5 On-Resistance VS Gate Source Voltage

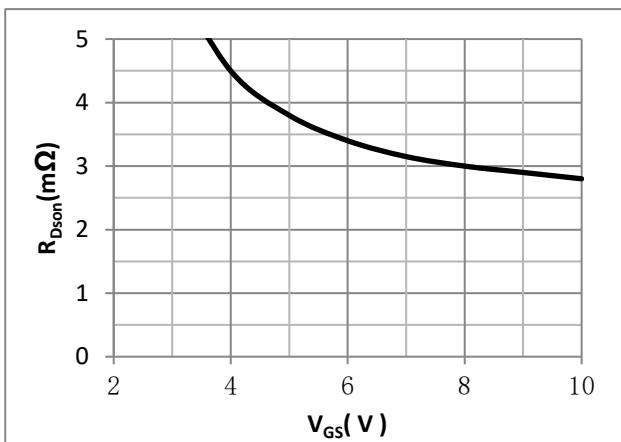


Fig.6 On-Resistance V.S Junction Temperature

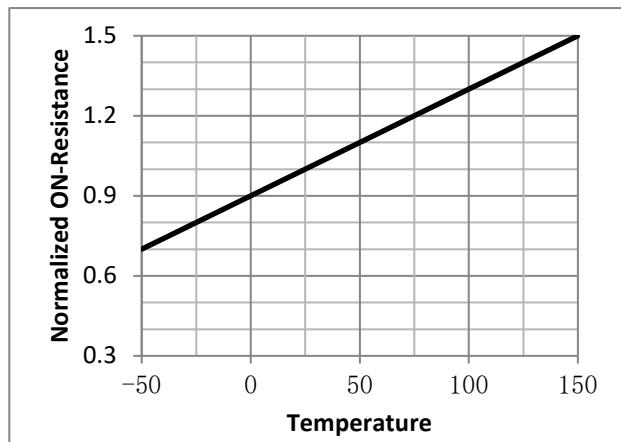


Fig.7 SOA Maximum Safe Operating Area

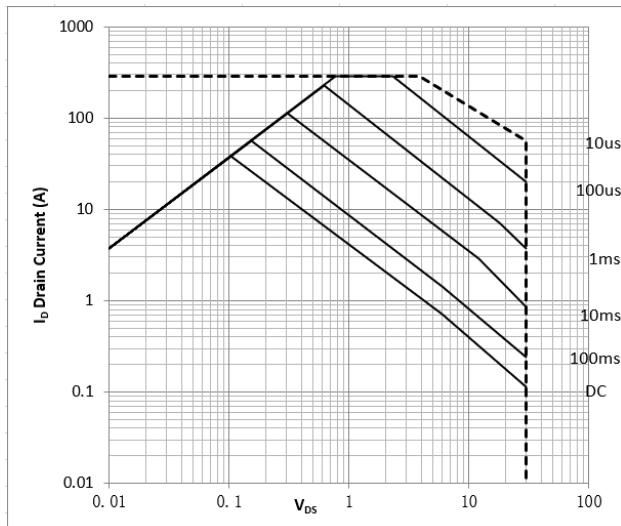


Fig.8 ID-Junction Temperature

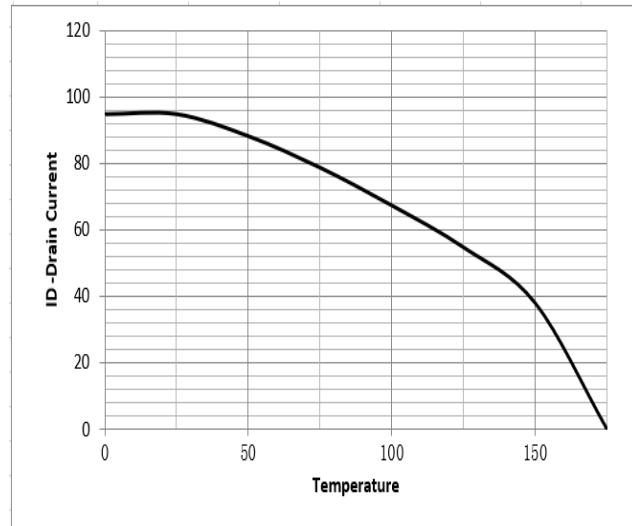


Figure 9. Diode Forward Voltage vs. Current

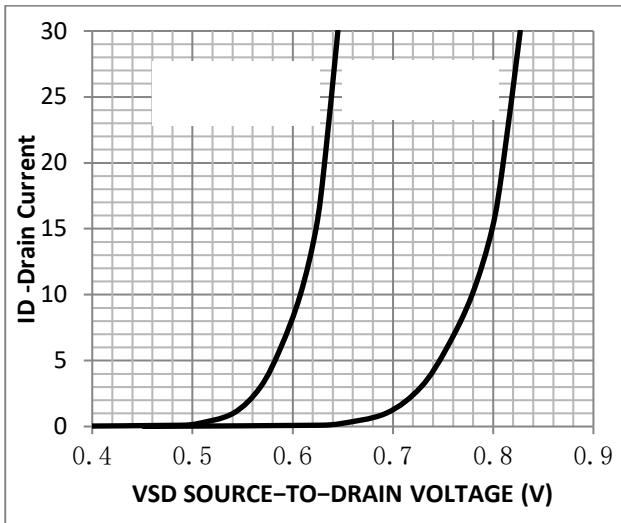


Figure 10. Transfer Characteristics

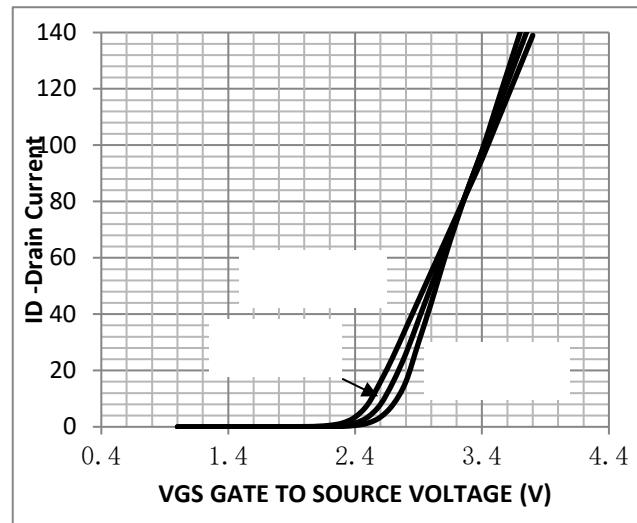




Figure 11. Gate-to-Source and
Drain-to-Source Voltage vs. Total Charge

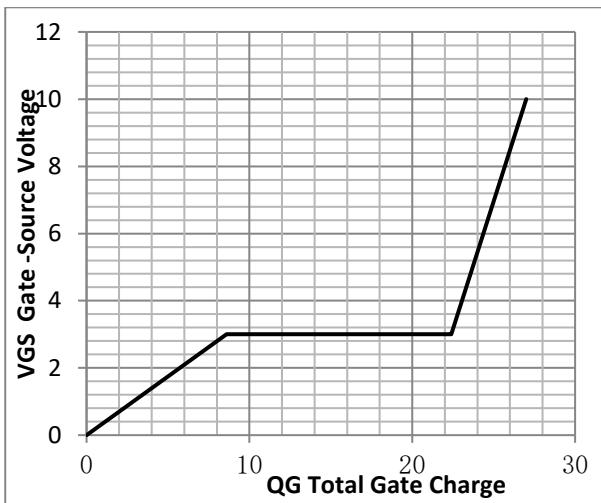


Fig.12 Capacitance Variation

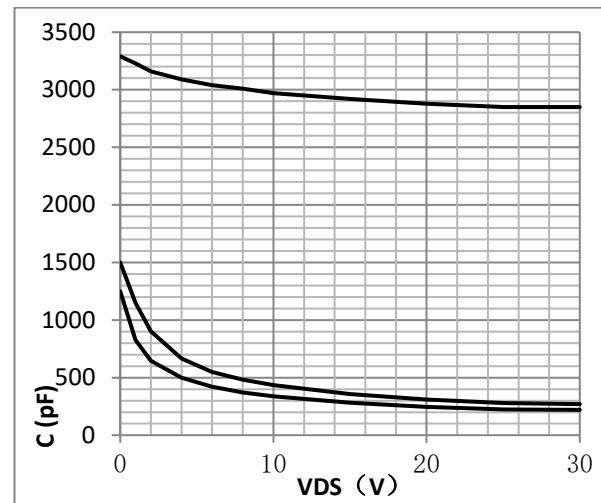


Fig.13 Switching Time Measurement Circuit

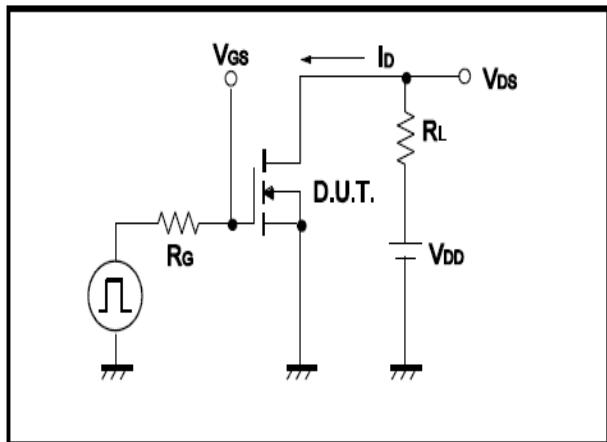


Fig.14 Gate Charge Waveform

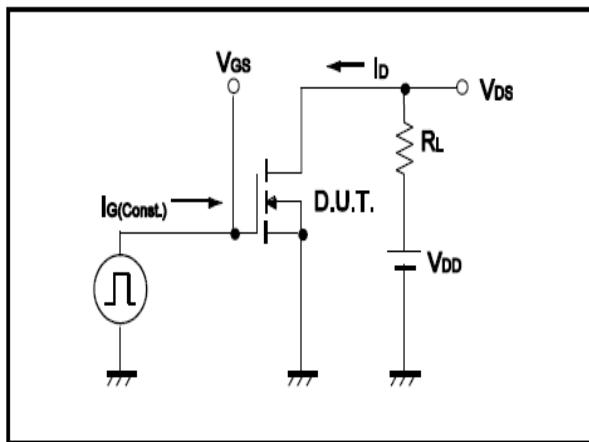


Fig.15 Avalanche Measurement Circuit

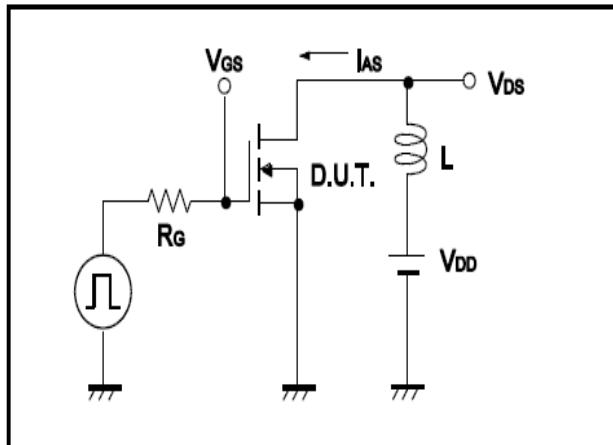


Fig.16 Avalanche Waveform

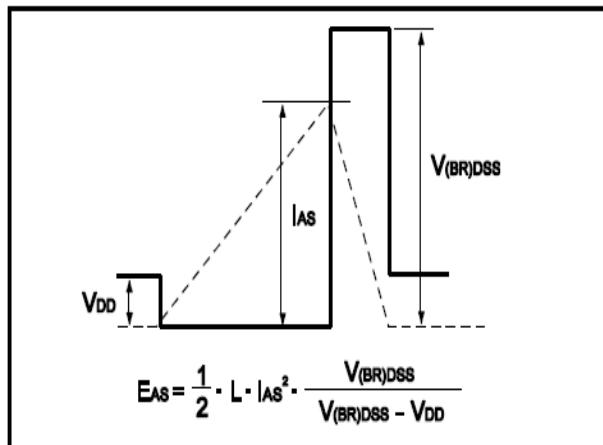
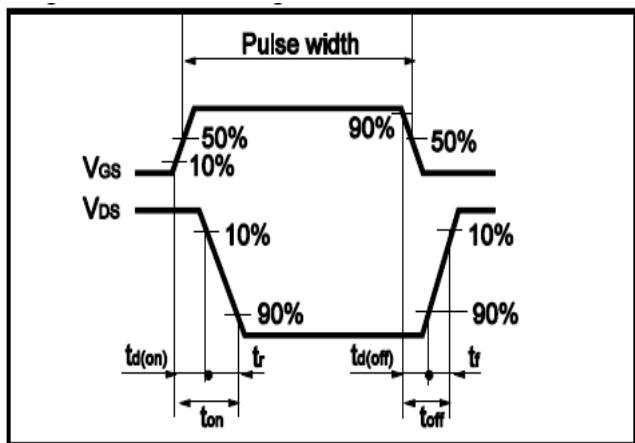




Fig.17 Gate Charge Waveform





Dimensions (TO-220F)

Unit: mm

| SYMBOL | min | nom | max | SYMBOL | min | nom | max |
|--------|-------|-------|-------|--------|------|------|------|
| C | 4.50 | 4.70 | 4.90 | b1 | 2.90 | 3.40 | 3.90 |
| c | 0.40 | 0.50 | 0.6 | a | 1.08 | 1.28 | 1.48 |
| A | 9.96 | 10.16 | 10.36 | a1 | 0.70 | 0.80 | 0.9 |
| B | 15.67 | 15.87 | 16.07 | E | 2.34 | 2.54 | 2.74 |
| B1 | 3.30 | 3.40 | 3.50 | E1 | 2.34 | 2.54 | 2.74 |
| R | 3.08 | 3.18 | 3.28 | C1 | 2.34 | 2.54 | 2.74 |
| b | 12.48 | 12.98 | 13.48 | C2 | 2.56 | 2.76 | 2.96 |
| | | | | | | | |

